

**Notice of References Cited**

Application/Control No.

10/814,232

Applicant(s)/Patent Under  
Reexamination  
TAKENAKA ET AL.

Examiner

Nathan A. Bowers

Art Unit

1744

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0011478	01-2006	Fouillet et al.	204/451
*	B	US-2005/0221373	10-2005	Enzelberger et al.	435/006
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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